

## 10-MHz TO 40-MHz, 10:1 LVDS SERIALIZER/DESERIALIZER

### FEATURES

- 100-Mbps to 400-Mbps Serial LVDS Data Payload Bandwidth at 10-MHz to 40-MHz System Clock
- Pin-Compatible Superset of NSM DS92LV1021/DS92LV1212
- Chipset (Serializer/Deserializer) Power Consumption <350 mW (Typ) at 40 MHz
- Synchronization Mode for Faster Lock
- Lock Indicator
- No External Components Required for PLL
- Low-Cost 28-Pin SSOP Package
- Industrial Temperature Qualified,  $T_A = -40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$
- Programmable Edge Trigger on Clock (Rising or Falling Edge)
- Flow-Through Pinout for Easy PCB Layout

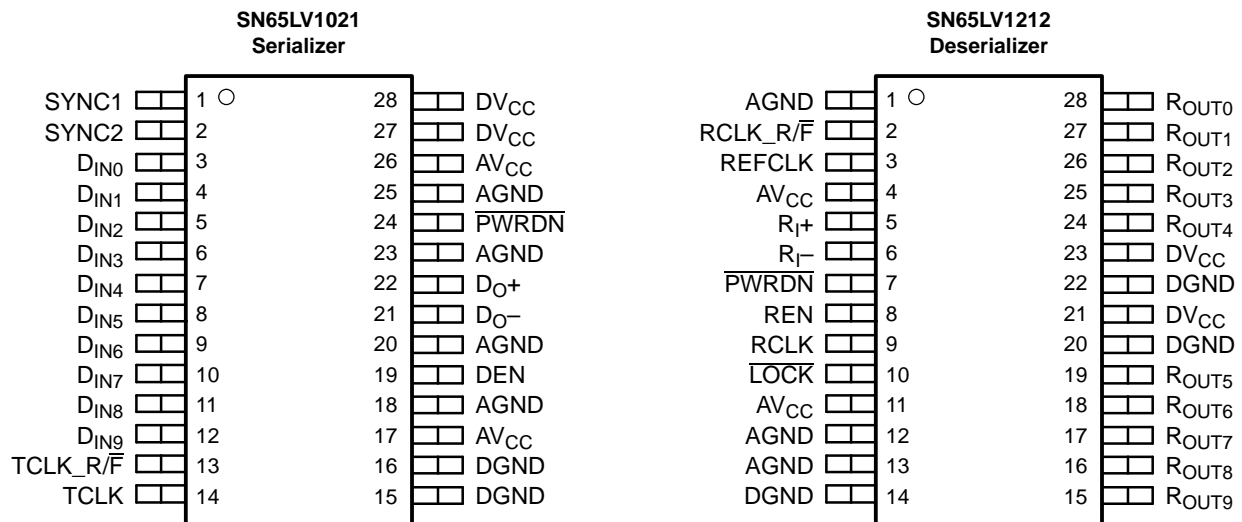
### DESCRIPTION

The SN65LV1021 serializer and SN65LV1212 deserializer comprise a 10-bit serdes chipset designed to transmit and receive serial data over LVDS differential backplanes at equivalent parallel word rates from 10 MHz to 40 MHz. Including overhead, this translates into a serial data rate between 120-Mbps and 480-Mbps payload-encoded throughput.

Upon power up, the chipset link can be initialized via a synchronization mode with internally generated SYNC patterns, or the deserializer can be allowed to synchronize to random data. By using the synchronization mode, the deserializer establishes lock within specified, shorter time parameters.

The device can be entered into a power-down state when no data transfer is required. Alternatively, a mode is available to place the output pins in the high-impedance state without losing PLL lock.

The SN65LV1021 and SN65LV1212 are characterized for operation over ambient air temperature of  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .



### ORDERING INFORMATION

DEVICE	PART NUMBER
Serializer	SN65LV1021DB
Deserializer	SN65LV1212DB

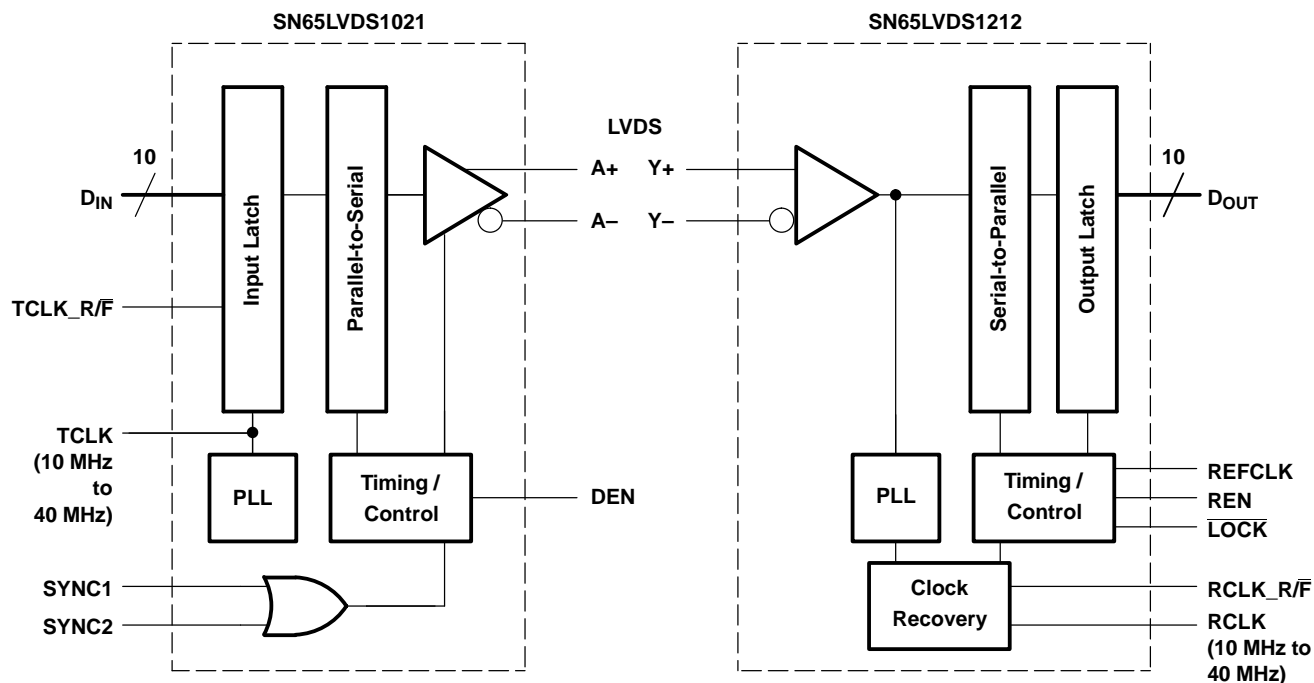


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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## BLOCK DIAGRAMS



## FUNCTIONAL DESCRIPTION

The SN65LV1021 and SN65LV1212 are a 10-bit serializer/deserializer chipset designed to transmit data over differential backplanes or unshielded twisted pair (UTP) at clock speeds from 10 MHz to 40 MHz. The chipset has five states of operation: initialization mode, synchronization mode, data transmission mode, power-down mode, and high-impedance mode. The following sections describe each state of operation.

### INITIALIZATION MODE

Initialization of both devices must occur before data transmission can commence. Initialization refers to synchronization of the serializer and deserializer PLLs to local clocks.

When  $V_{CC}$  is applied to the serializer and/or deserializer, the respective outputs enter the high-impedance state, while on-chip power-on circuitry disables internal circuitry. When  $V_{CC}$  reaches 2.45 V, the PLL in each device begins locking to a local clock. For the serializer, the local clock is the transmit clock (TCLK) provided by an external source. For the deserializer, a local clock must be applied to the REFCLK pin. The serializer outputs remain in the high-impedance state, while the PLL locks to the TCLK.

### SYNCHRONIZATION MODE

The deserializer PLL must synchronize to the serializer in order to receive valid data. Synchronization can be accomplished in one of two ways:

- **RAPID SYNCHRONIZATION:** The serializer has the capability to send specific SYNC patterns consisting of six ones and six zeros switching at the input clock rate. The transmission of SYNC patterns enables the deserializer to lock to the serializer signal within a deterministic time frame. This transmission of SYNC patterns is selected via the SYNC1 and SYNC2 inputs on the serializer. Upon receiving valid a SYNC1 or SYNC2 pulse (wider than 6 clock cycles), 1026 cycles of SYNC pattern are sent.

## FUNCTIONAL DESCRIPTION (continued)

When the deserializer detects edge transitions at the LVDS input, it attempts to lock to the embedded clock information. The deserializer  $\overline{\text{LOCK}}$  output remains high while its PLL locks to the incoming data or SYNC patterns present on the serial input. When the deserializer locks to the LVDS data, the  $\overline{\text{LOCK}}$  output goes low. When  $\overline{\text{LOCK}}$  is low, the deserializer outputs represent incoming LVDS data. One approach is to tie the deserializer  $\overline{\text{LOCK}}$  output directly to SYNC1 or SYNC2.

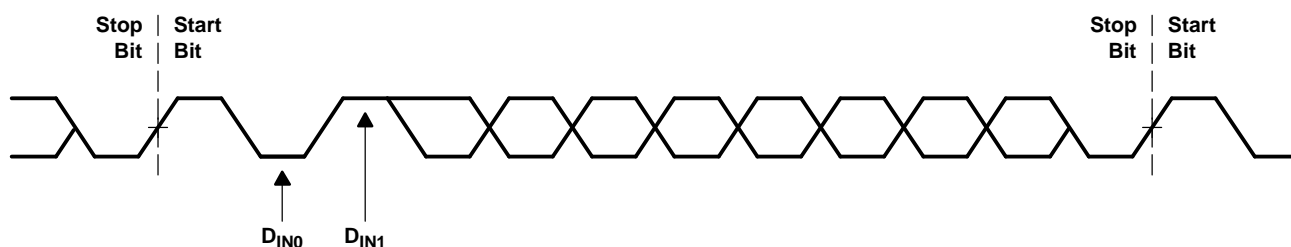
- RANDOM-LOCK SYNCHRONIZATION:** The deserializer can attain lock to a data stream without requiring the serializer to send special SYNC patterns. This allows the SN65LV1212 to operate in open-loop applications. Equally important is the deserializer's ability to support hot insertion into a running backplane. In the open-loop or hot-insertion case, it is assumed the data stream is essentially random. Therefore, because lock time varies due to data stream characteristics, the exact lock time cannot be predicted. The primary constraint on the random lock time is the initial phase relation between the incoming data and the REFCLK when the deserializer powers up.

The data contained in the data stream can also affect lock time. If a specific pattern is repetitive, the deserializer could enter false lock—falsely recognizing the data pattern as the start/stop bits. This is referred to as repetitive multitransition (RMT); see [Figure 1](#) for RMT examples. RMT occurs when more than one low-high transition takes place per clock cycle over multiple cycles. In the worst case, the deserializer could become locked to the data pattern rather than the clock. Circuitry within the deserializer can detect that the possibility of false lock exists. Upon detection, the circuitry prevents the  $\overline{\text{LOCK}}$  output from becoming active until the potential false lock pattern changes. Notice that the RMT pattern only affects the deserializer lock time, and once the deserializer is in lock, the RMT pattern does not affect the deserializer state as long as the same data boundary happens each cycle. The deserializer does not go into lock until it finds a unique four consecutive cycles of data boundary (stop/start bits) at the same position.

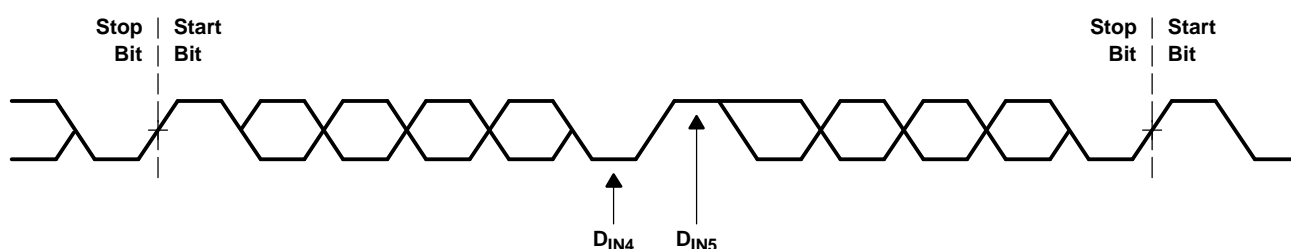
The deserializer stays in lock until it cannot detect the same data boundary (stop/start bits) for four consecutive cycles. Then the deserializer goes out of lock and hunts for the new data boundary (stop/start bits). In the event of loss of synchronization, the  $\overline{\text{LOCK}}$  pin output goes high and the outputs (including RCLK) enter a high-impedance state. The user's system should monitor the  $\overline{\text{LOCK}}$  pin in order to detect a loss of synchronization. Upon detection of loss of lock, sending sync patterns for resynchronization is desirable if reestablishing lock within a specific time is critical. However, the deserializer can lock to random data as previously noted.

## FUNCTIONAL DESCRIPTION (continued)

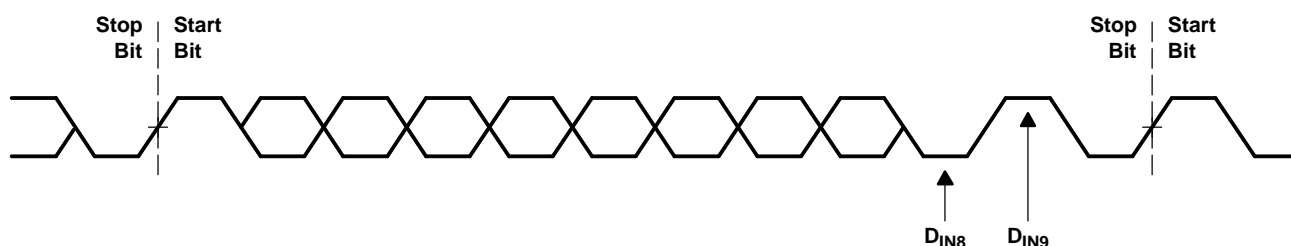
**D<sub>IN0</sub> Held Low and D<sub>IN1</sub> Held High**



**D<sub>IN4</sub> Held Low and D<sub>IN5</sub> Held High**



**D<sub>IN8</sub> Held Low and D<sub>IN9</sub> Held High**



**Figure 1. RMT Pattern Examples**

## DATA TRANSMISSION MODE

After initialization and synchronization, the serializer accepts parallel data from inputs D<sub>IN0</sub>-D<sub>IN9</sub>. The serializer uses the TCLK input to latch the incoming data. The TCLK\_R/ $\overline{F}$  pin selects which edge the serializer uses to strobe incoming data. If either of the SYNC inputs is high for 6 TCLK cycles, the data at D<sub>IN0</sub>-D<sub>IN9</sub> is ignored regardless of the clock edge selected and 1026 cycles of SYNC pattern are sent.

After determining which clock edge to use, a start and stop bit, appended internally, frames the data bits in the register. The start bit is always high and the stop bit is always low. The start and stop bits function as the embedded clock bits in the serial stream.

The serializer transmits serialized data and appended clock bits (10+2 bits) from the serial data output (DO $\pm$ ) at 12 times the TCLK frequency. For example, if TCLK is 10 MHz, the serial rate is 10  $\times$  12 = 120 Mbps. Because only 10 bits are input data, the useful data rate is 10 times the TCLK frequency. For instance, if TCLK = 12 MHz, the useful data rate is 10  $\times$  12 = 120 Mbps. The data source, which provides TCLK, must be in the range of 10 MHz to 40 MHz.

The serializer outputs (DO $\pm$ ) can drive point-to-point connections or limited multipoint or multidrop backplanes. The outputs transmit data when the enable pin (DEN) is high,  $\overline{PWRDN}$  is high, and SYNC1 and SYNC2 are low. When DEN is driven low, the serializer output pins enter the high-impedance state.

## FUNCTIONAL DESCRIPTION (continued)

Once the deserializer has synchronized to the serializer, the  $\overline{\text{LOCK}}$  pin transitions low. The deserializer locks to the embedded clock and uses it to recover the serialized data.  $\text{R}_{\text{OUT}x}$  data is valid when  $\overline{\text{LOCK}}$  is low, otherwise  $\text{R}_{\text{OUT}0}\text{--}\text{R}_{\text{OUT}9}$  is invalid. The  $\text{R}_{\text{OUT}0}\text{--}\text{R}_{\text{OUT}9}$  data is strobed out by RCLK. The specific RCLK edge polarity to be used is selected by the RCLK\_R/F input. The  $\text{R}_{\text{OUT}0}\text{--}\text{R}_{\text{OUT}9}$ ,  $\overline{\text{LOCK}}$  and RCLK outputs can drive a maximum of three CMOS input gates (15-pF load, total for all three) with a 40-MHz clock.

## POWER DOWN

When no data transfer is required, the power-down mode can be used. The serializer and deserializer use the power-down mode, a low-power sleep mode, to reduce power consumption. The deserializer enters power down when you drive  $\overline{\text{PWRDN}}$  and REN low. The serializer enters power down when the  $\overline{\text{PWRDN}}$  is driven low. In power down, the PLL stops and the outputs enter a high-impedance state, which disables load current and reduces supply current to the milliampere range. To exit power down, you must drive the  $\overline{\text{PWRDN}}$  pin high.

Before valid data exchanges between the serializer and deserializer can resume, you must reinitialize and resynchronize the devices to each other. Initialization of the serializer takes 1026 TCLK cycles. The deserializer initializes and drives  $\overline{\text{LOCK}}$  high until lock to the LVDS clock occurs.

## HIGH-IMPEDANCE MODE

The serializer enters the high-impedance mode when the DEN pin is driven low. This puts both driver output pins (DO+ and DO-) into a high-impedance state. When you drive DEN high, the serializer returns to its previous state, as long as all other control pins remain static ( $\overline{\text{SYNC1}}$ ,  $\overline{\text{SYNC2}}$ ,  $\overline{\text{PWRDN}}$ , TCLK\_R/F). When the REN pin is driven low, the deserializer enters high-impedance mode. Consequently, the receiver output pins ( $\text{R}_{\text{OUT}0}\text{--}\text{R}_{\text{OUT}9}$ ) and RCLK are placed into the high-impedance state. The  $\overline{\text{LOCK}}$  output remains active, reflecting the state of the PLL.

Deserializer Truth Table

INPUTS		OUTPUTS		
$\overline{\text{PWRDN}}$	REN	$\text{ROUT}[0:9]$	$\overline{\text{LOCK}}^{(1), (2)}$	RCLK <sup>(3)</sup>
H	H	Z	H	Z
H	H	Active	L	Active
L	X	Z	Z	Z
H	L	Z	Active	Z

(1)  $\overline{\text{LOCK}}$  output reflects the state of the deserializer with regard to the selected data stream.

(2) ROUT and RCLK are 3-stated when  $\overline{\text{LOCK}}$  is asserted high.

(3) RCLK active indicates the RCLK is running if the deserializer is locked. The timing of RCLK with respect to ROUT is determined by RCLK\_R/F.

## TERMINAL FUNCTIONS

PIN	NAME	DESCRIPTION
<b>SERIALIZER</b>		
1, 2	SYNC1, SYNC2	LVTTL logic inputs SYNC1 and SYNC2 are ORed together. When at least one of the two pins is asserted high for 6 cycles of TCLK, the serializer initiates transmission of a minimum 1026 SYNC patterns. If after completion of transmission of 1026 patterns SYNC continues to be asserted, then the transmission continues until SYNC is driven low and if the time SYNC holds > 6 cycles, another 1026 SYNC pattern transmission initiates.
3-12	D <sub>IN0</sub> -D <sub>IN9</sub>	Parallel LVTTL data inputs
13	TCLK_R/F	LVTTL logic input. Low selects a TCLK falling-edge data strobe; high selects a TCLK rising-edge data strobe.
14	TCLK	LVTTL-level reference clock input. The SN65LV1021 accepts a 10-MHz to 40-MHz clock. TCLK strobes parallel data into the input latch and provides a reference frequency to the PLL.
15, 16	DGND	Digital circuit ground
18, 20, 23, 25	AGND	Analog circuit ground (PLL and analog circuits)
17, 26	AV <sub>CC</sub>	Analog circuit power supply (PLL and analog circuits)
19	DEN	LVTTL logic input. Low puts the LVDS serial output into the high-impedance state. High enables serial data output.
21	D <sub>O-</sub>	Inverting LVDS differential output
22	D <sub>O+</sub>	Noninverting LVDS differential output
27, 28	DV <sub>CC</sub>	Digital circuit power supply
24	PWRDN	LVTTL logic input. Asserting this pin low turns off the PLL and places the outputs into the high-impedance state, putting the device into a low-power mode.
<b>DESERIALIZER</b>		
3	REFCLK	LVTTL logic input. Use this pin to supply a REFCLK signal for the internal PLL frequency.
15-19, 24-28	R <sub>OUT0</sub> -R <sub>OUT9</sub>	Parallel LVTTL data outputs
2	RCLK_R/F	LVTTL logic input. Low selects an RCLK falling-edge data strobe; high selects an RCLK rising-edge data strobe.
9	RCLK	LVTTL-level output recovered clock. Use RCLK to strobe R <sub>OUTx</sub> .
14, 20, 22	DGND	Digital circuit ground
1, 12, 13	AGND	Analog circuit ground (PLL and analog circuits)
4, 11	AV <sub>CC</sub>	Analog circuit power supply (PLL and analog circuits)
8	REN	LVTTL logic input. Low places R <sub>OUT0</sub> -R <sub>OUT9</sub> , $\overline{\text{LOCK}}$ , and RCLK in the high-impedance state.
5	R <sub>I+</sub>	Serial data input. Noninverting LVDS differential input
6	R <sub>I-</sub>	Serial data input. Inverting LVDS differential input
10	$\overline{\text{LOCK}}$	LVTTL-level output. $\overline{\text{LOCK}}$ goes low when the deserializer PLL locks onto the embedded clock edge.
21, 23	DV <sub>CC</sub>	Digital circuit power supply
7	PWRDN	LVTTL logic input. Asserting this pin low turns off the PLL and places outputs into a high-impedance state, putting the device into a low-power mode.

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

		UNIT
V <sub>CC</sub> to GND		-0.3 V to 4 V
	LVTTTL input voltage	-0.3 V to (V <sub>CC</sub> + 0.3 V)
	LVTTTL output voltage	-0.3 V to (V <sub>CC</sub> + 0.3 V)
	LVDS receiver input voltage	-0.3 V to 3.9 V
	LVDS driver output voltage	-0.3 V to 3.9 V
	LVDS output short circuit duration	Continuous
	Electrostatic discharge:	HBM
		MM
	Junction temperature	150°C
	Storage temperature	-65°C to 150°C
	Lead temperature (soldering, 4 seconds)	260°C
T <sub>A</sub> = 25°C	Maximum package power dissipation	1.27 W
	Package derating	10.3 mW/°C above 25°C

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
V <sub>CC</sub> <sup>(1)</sup>	Supply voltage	3	3.3	3.6	V
	Receiver input voltage range	0		2.4	V
V <sub>CM</sub>	Receiver input common mode range	$\frac{ V_{ID} }{2}$	2.4 - $\frac{ V_{ID} }{2}$		V
	Supply noise voltage			100	mV <sub>P-P</sub>
T <sub>A</sub>	Operating free-air temperature	-40	25	85	°C

- (1) By design, DVCC and AVCC are separated internally and does not matter what the difference is for XDVC-~~AVCCX~~, as long as both are within 3 V to 3.6 V.

## ELECTRICAL CHARACTERISTICS

over recommended operating supply and temperature ranges (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>SERIALIZER LVCMOS/LVTTL DC SPECIFICATIONS (see Note <sup>(1)</sup>)</b>						
V <sub>IH</sub>	High-level input voltage		2		V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level input voltage		GND		0.8	V
V <sub>CL</sub>	Input clamp voltage	I <sub>CL</sub> = -18 mA			-1.5	V
I <sub>IN</sub>	Input current (see Note <sup>(2)</sup> )	V <sub>IN</sub> = 0 V or 3.6 V	-200	±100	200	μA
<b>DESERIALIZER LVCMOS/LVTTL DC SPECIFICATIONS (see Note <sup>(3)</sup>)</b>						
V <sub>IH</sub>	High-level input voltage		2		V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level input voltage		GND		0.8	V
V <sub>CL</sub>	Input clamp voltage	I <sub>CL</sub> = -18 mA		-0.62	-1.5	V
I <sub>IN</sub>	Input current	V <sub>IN</sub> = 0 V or 3.6 V	-200		200	μA
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -5 mA	2.2	3	V <sub>CC</sub>	V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 5 mA	GND	0.25	0.5	V
I <sub>OS</sub>	Output short-circuit current	V <sub>OUT</sub> = 0 V	-15	-47	-85	mA

- (1) Apply to D<sub>IN0</sub>-D<sub>IN9</sub>, TCLK, PWRDN, TCLK\_R/F, SYNC1, SYNC2, DEN

- (2) High I<sub>IN</sub> values are due to pull-up and pull-down resistors on the inputs.

- (3) Apply to input pins PWRDN, RCLK\_R/F, REN, REFCLK; apply to output pins R<sub>OUTX</sub>, RCLK, LOCK

## ELECTRICAL CHARACTERISTICS (continued)

over recommended operating supply and temperature ranges (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I <sub>OZ</sub>	High-impedance output current	PWRDN or REN = 0.8 V, V <sub>OUT</sub> = 0 V or V <sub>CC</sub>	-10	±1	10	µA
SERIALIZER LVDS DC SPECIFICATIONS (apply to pins DO+ and DO-)						
V <sub>OD</sub>	Output differential voltage (DO+)-(DO-)	R <sub>L</sub> = 27 Ω, See <a href="#">Figure 18</a>	350	400		mV
ΔV <sub>OD</sub>	Output differential voltage unbalance				35	mV
V <sub>OS</sub>	Offset voltage		1.1	1.2	1.3	V
ΔV <sub>OS</sub>	Offset voltage unbalance				35	mV
I <sub>OS</sub>	Output short circuit current	DO = 0 V, D <sub>INx</sub> = high, PWRDN and DEN = 2.4 V		-10	-90	mA
I <sub>OZ</sub>	High-impedance output current	PWRDN or DEN = 0.8 V, DO = 0 V or V <sub>CC</sub>	-10	±1	10	µA
I <sub>OX</sub>	Power-off output current	V <sub>CC</sub> = 0 V, DO = 0 V or V <sub>CC</sub>	-20	±1	20	µA
DESERIALIZER LVDS DC SPECIFICATIONS (apply to pins RI+ and RI-)						
V <sub>TH</sub>	Differential threshold high voltage	V <sub>CM</sub> = 1.1 V			50	mV
V <sub>TL</sub>	Differential threshold low voltage		-50			mV
I <sub>IN</sub>	Input current	V <sub>IN</sub> = 2.4 V, V <sub>CC</sub> = 3.6 V or 0 V	-10	±1	15	µA
		V <sub>IN</sub> = 0 V, V <sub>CC</sub> = 3.6 V or 0 V	-10	±0.05	10	
SERIALIZER SUPPLY CURRENT (applies to pins DVCC and AVCC)						
I <sub>CCD</sub>	Serializer supply current, worst case	R <sub>L</sub> = 27 Ω, See <a href="#">Figure 2</a>	f = 40 MHz	40	50	mA
			f = 10 MHz	20	25	
I <sub>CCXD</sub>	Serializer supply current, power down	PWRDN = 0.8 V		200	500	µA
DESERIALIZER SUPPLY CURRENT (applies to pins DVCC and AVCC)						
I <sub>CCR</sub>	Deserializer supply current, worst case	C <sub>L</sub> = 15 pF, See <a href="#">Figure 3</a>	f = 40 MHz	63	75	mA
			f = 10 MHz	15	35	
I <sub>CCXR</sub>	Deserializer supply current, power down	PWRDN = 0.8 V, REN = 0.8 V		0.36	1	mA

## SERIALIZER TIMING REQUIREMENTS FOR TCLK

over recommended operating supply and temperature ranges (unless otherwise specified)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{TCP}$ Transmit clock period		25	T	100	ns
$t_{TCIH}$ Transmit clock high time		0.4T	0.5T	0.6T	ns
$t_{TCIL}$ Transmit clock low time		0.4T	0.5T	0.6T	ns
$t_{i(CLK)}$ TCLK input transition time	See <a href="#">Figure 6</a>		3	6	ns
$t_{JIT}$ TCLK input jitter				150	ps (RMS)



## SERIALIZER SWITCHING CHARACTERISTICS

over recommended operating supply and temperature ranges (unless otherwise specified)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{TLH(L)}$ LVDS low-to-high transition time	$R_L = 27\ \Omega$ , $C_L = 10\ \text{pF}$ to GND, See Figure 4		0.2	1	ns
$t_{THL(L)}$ LVDS high-to-low transition time			0.25	1	
$t_{su(DI)}$ $D_{IN0}$ - $D_{IN9}$ setup to TCLK	$R_L = 27\ \Omega$ , $C_L = 10\ \text{pF}$ to GND, See Figure 7	1	0		
$t_{h(D)}$ $D_{IN0}$ - $D_{IN9}$ hold from TCLK		6.5	4.5		
$t_{d(HZ)}$ $DO\pm$ high-to-high impedance state delay	$R_L = 27\ \Omega$ , $C_L = 10\ \text{pF}$ to GND, See Figure 8		2.5	5	
$t_{d(LZ)}$ $DO\pm$ low-to-high impedance state delay			2.5	5	
$t_{d(ZH)}$ $DO\pm$ high-impedance state-to-high delay			2.5	10	
$t_{d(ZL)}$ $DO\pm$ high-impedance state-to-low delay			2.7	10	
$t_{w(SP)}$ SYNC pulse duration	$R_L = 27\ \Omega$ , See Figure 9 and Figure 10	$6 \times t_{TCP}$			
$t_{PLD}$ Serializer PLL lock time		$1026 \times t_{TCP}$			
$t_{d(S)}$ Serializer delay	$R_L = 27\ \Omega$ , See Figure 11			$\frac{t_{TCP}}{2} + 3$	
$t_{(BIT)}$ Bus LVDS bit width	$R_L = 27\ \Omega$ , $C_L = 10\ \text{pF}$ to GND		$t_{CLK}/12$		

## DESERIALIZER TIMING REQUIREMENTS FOR REFCLK

over recommended operating supply and temperature ranges (unless otherwise specified)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{RFCP}$ REFCLK period		25	T	100	ns
$t_{RFDC}$ REFCLK duty cycle		40%	50%	60%	
$t_{l(RF)}$ REFCLK transition time			3	6	ns
Frequency tolerance		-100		+100	ppm

## DESERIALIZER SWITCHING CHARACTERISTICS

over recommended operating supply and temperature ranges (unless otherwise specified)

PARAMETER	TEST CONDITIONS	PIN/FREQ	MIN	TYP	MAX	UNIT
$t_{RCP}$ Receiver out clock period	$t_{(RCP)} = t_{(TCP)}$ See Figure 11	RCLK	25		100	ns
$t_{TLH(C)}$ CMOS/TTL low-to-high transition time	$C_L = 15\ \text{pF}$ , See Figure 5	$R_{OUT0}$ - $R_{OUT9}$ , $\overline{LOC}$ , RCLK		0.7	2.5	
$t_{THL(C)}$ CMOS/TTL high-to-low transition time				1.1	2.5	
$t_{d(D)}$ Deserializer delay, See Figure 12	Room temperature, 3.3 V	10 MHz	$2 \times t_{RCP} + 9$		$2.833 \times t_{RCP} + 14$	
		40 MHz	$2 \times t_{RCP} + 6$		$2.833 \times t_{RCP} + 10$	ns
$t_{su(ROS)}$ $R_{OUT0}$ - $R_{OUT9}$ setup data to RCLK	See Figure 13	RCLK	$0.4 \times t_{RCP}$	$0.5 \times t_{RCP}$		
$t_{l(ROH)}$ $R_{OUT0}$ - $R_{OUT9}$ hold data to RCLK			$-0.4 \times t_{RCP}$	$-0.5 \times t_{RCP}$		
$t_{l(RDC)}$ RCLK duty cycle			40%	50%	60%	
$t_{d(HZ)}$ High-to-high impedance state delay	See Figure 14	$R_{OUT0}$ - $R_{OUT9}$ , LOCK		6.7	8	ns
$t_{d(LZ)}$ Low-to-high impedance state delay				4.6	8	
$t_{d(ZH)}$ High-impedance state-to-high delay				5.5	8	
$t_{d(ZL)}$ High-impedance state-to-low delay				4.8	8	

## DESERIALIZER SWITCHING CHARACTERISTICS (continued)

over recommended operating supply and temperature ranges (unless otherwise specified)

PARAMETER	TEST CONDITIONS	PIN/FREQ	MIN	TYP	MAX	UNIT
$t_{(DSR1)}$	Deserializer PLL lock time from PWRDN(with SYNCPAT)	10 MHz			$(1024+26)t_{RFCP}$	$\mu s$
		40 MHz			$(1024+26)t_{RFCP}$	
$t_{(DSR2)}$	Deserializer PLL lock time from SYNCPAT	10 MHz			0.7	
		40 MHz			0.2	
$t_{d(ZHL)}$	High-impedance state-to-high delay (power up)	LOCK			3	ns
$t_{(RNM)}$	Deserializer noise margin	10 MHz		3680		ps
		40 MHz		1100		

- (1)  $t_{(DSR1)}$  represents the time required for the deserializer to register that a lock has occurred upon power up or when leaving the power-down mode.  $t_{(DSR2)}$  represents the time required to register that a lock has occurred for the powered up and enabled deserializer when the input (RI±) conditions change from not receiving data to receiving synchronization patterns (SYNCPATs). In order to specify deserializer PLL performance  $t_{DSR1}$  and  $t_{DSR2}$  are specified with REFCLK active and stable and specific conditions of SYNCPATs.
- (2)  $t_{RNM}$  represents the phase noise or jitter that the deserializer can withstand in the incoming data stream before bit errors occur.

### TIMING DIAGRAMS AND TEST CIRCUITS

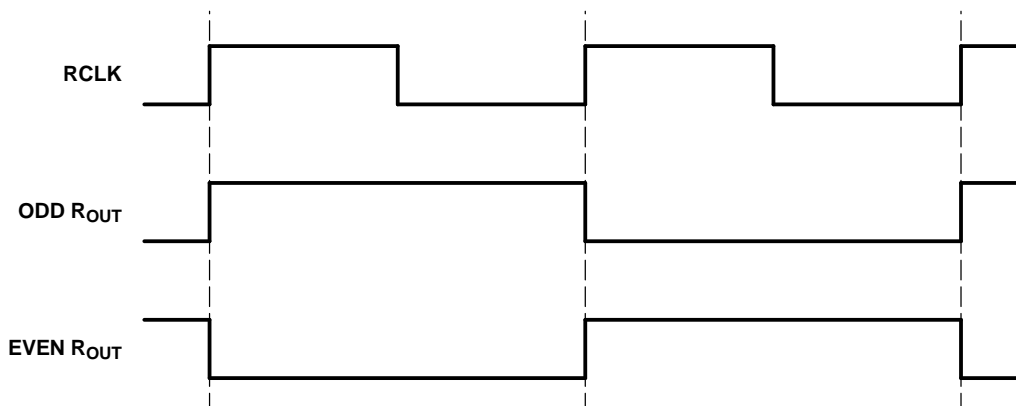


Figure 2. Worst-Case Serializer  $I_{CC}$  Test Pattern

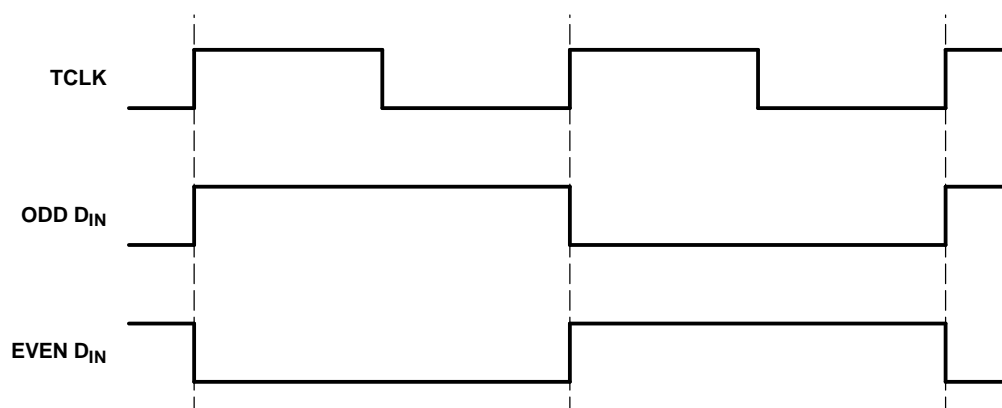


Figure 3. Worst-Case Deserializer  $I_{CC}$  Test Pattern

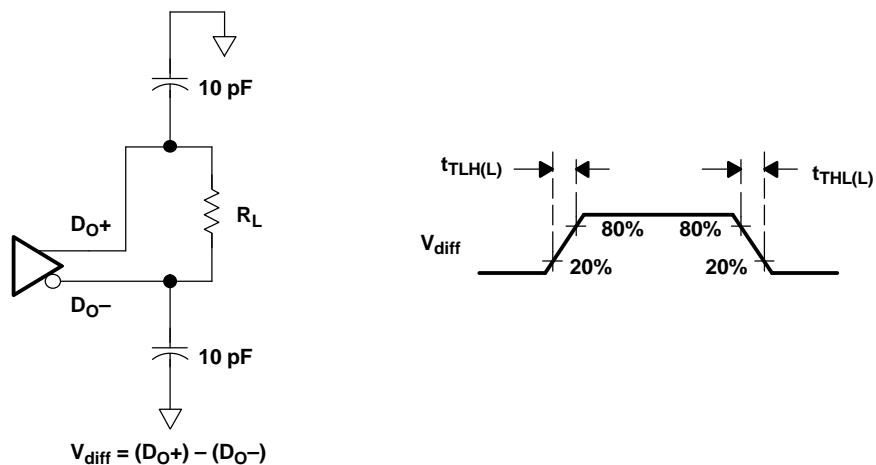


Figure 4. Serializer LVDS Output Load and Transition Times

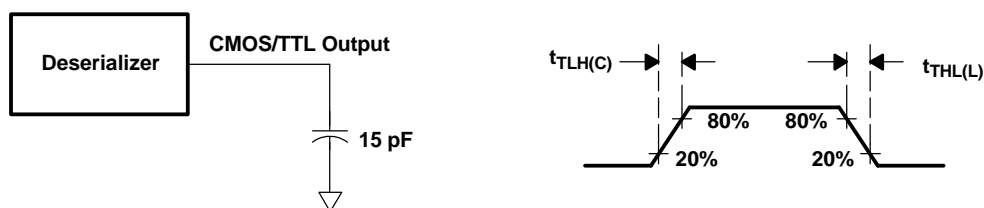


Figure 5. Deserializer CMOS/TTL Output Load and Transition Times

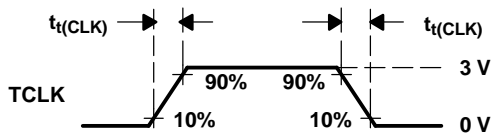


Figure 6. Serializer Input Clock Transition Time

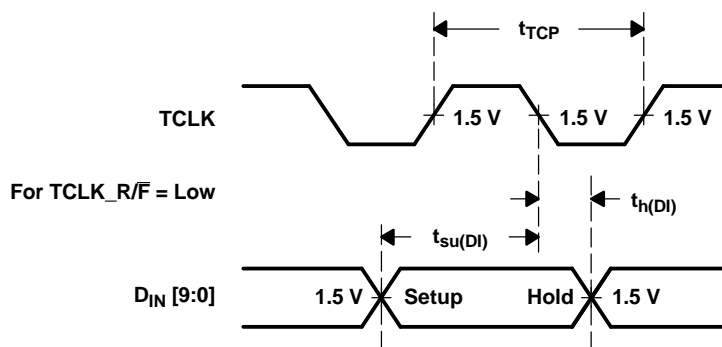


Figure 7. Serializer Setup/Hold Times

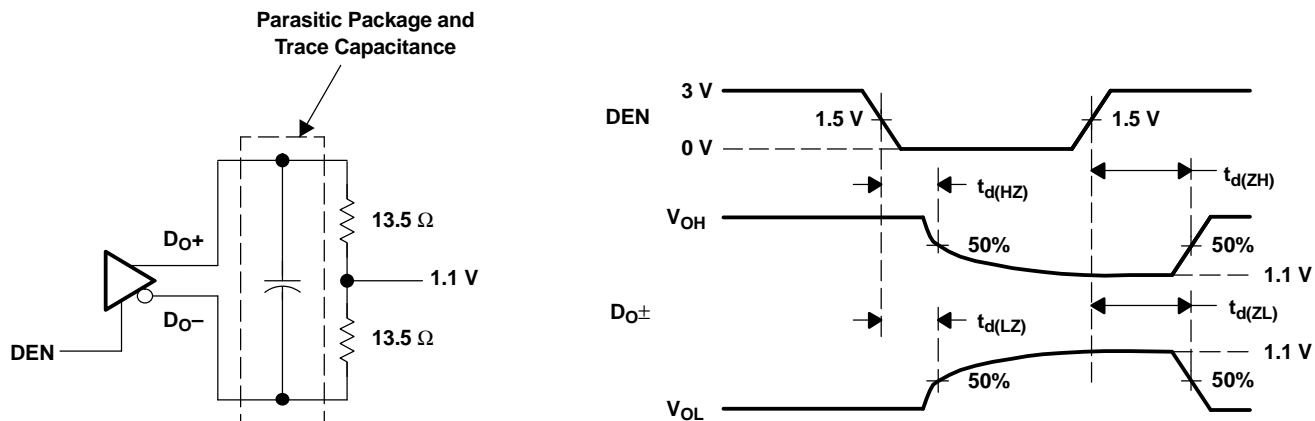


Figure 8. Serializer High-Impedance-State Test Circuit and Timing

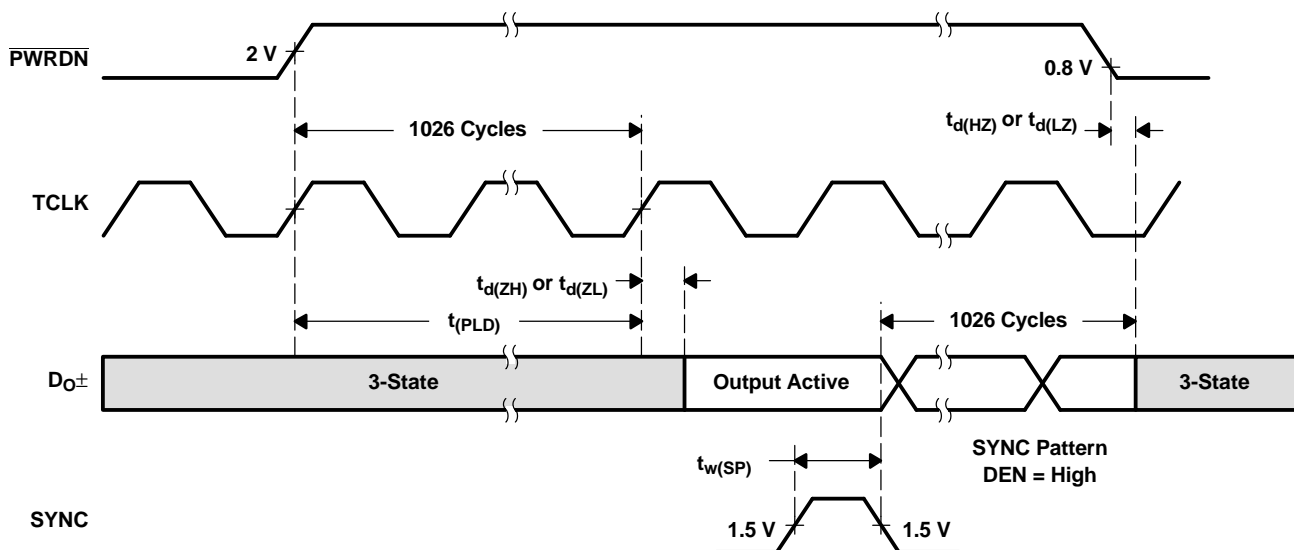


Figure 9. Serializer PLL Lock Time and  $\overline{PWRDN}$  High-Impedance-State Delays

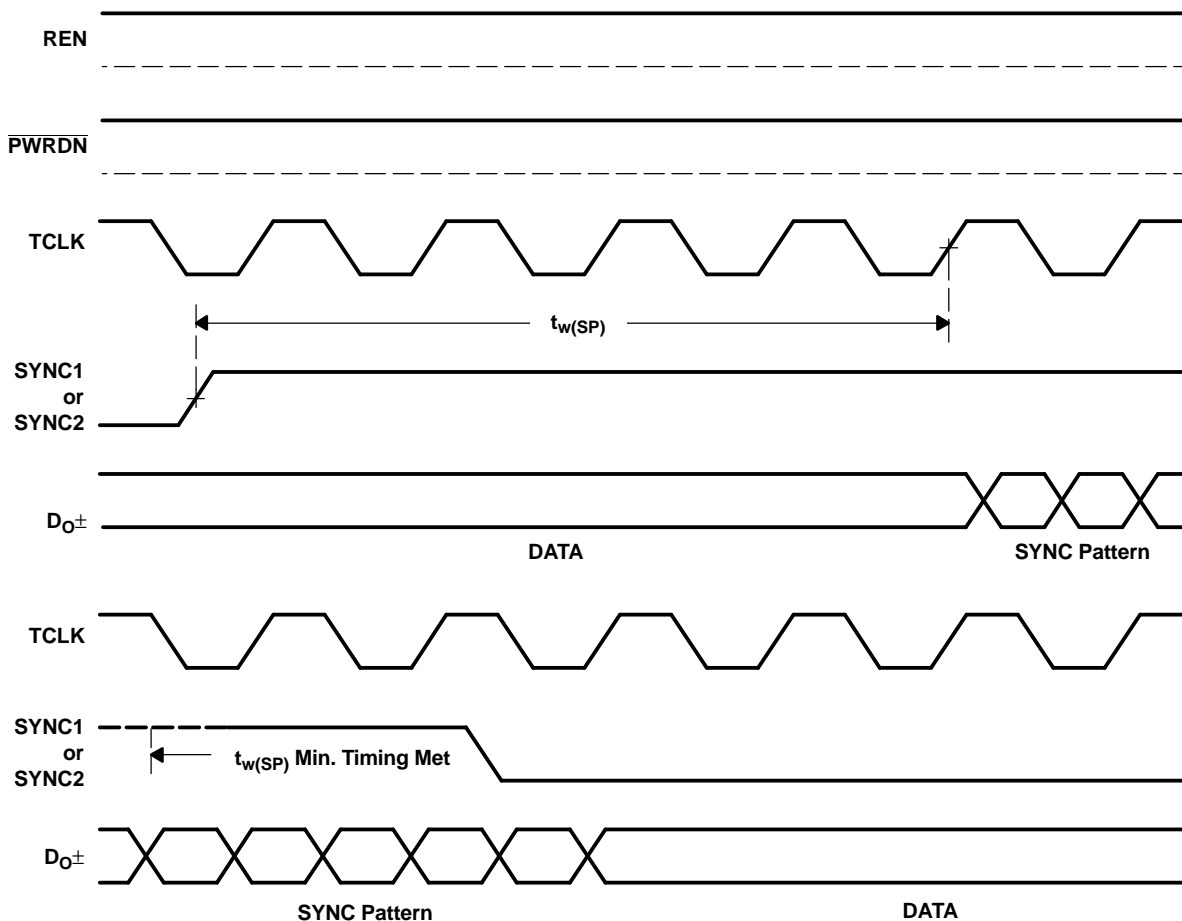


Figure 10. SYNC Timing Delays

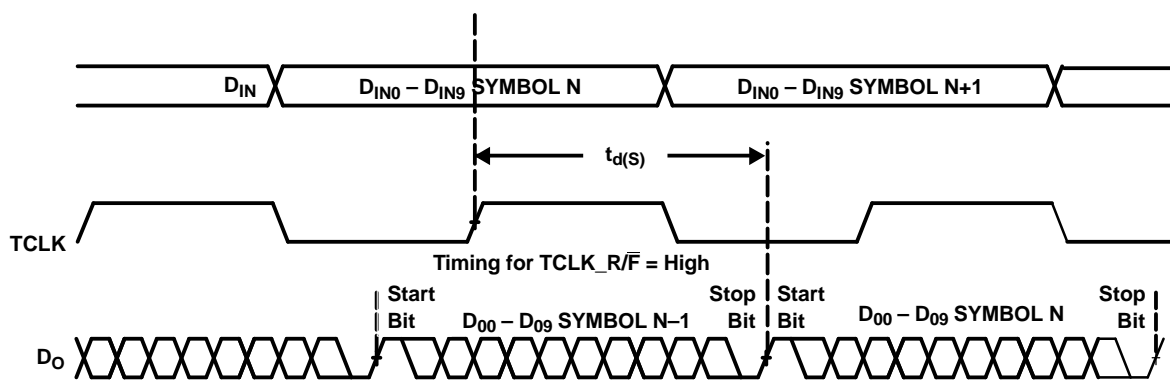


Figure 11. Serializer Delay

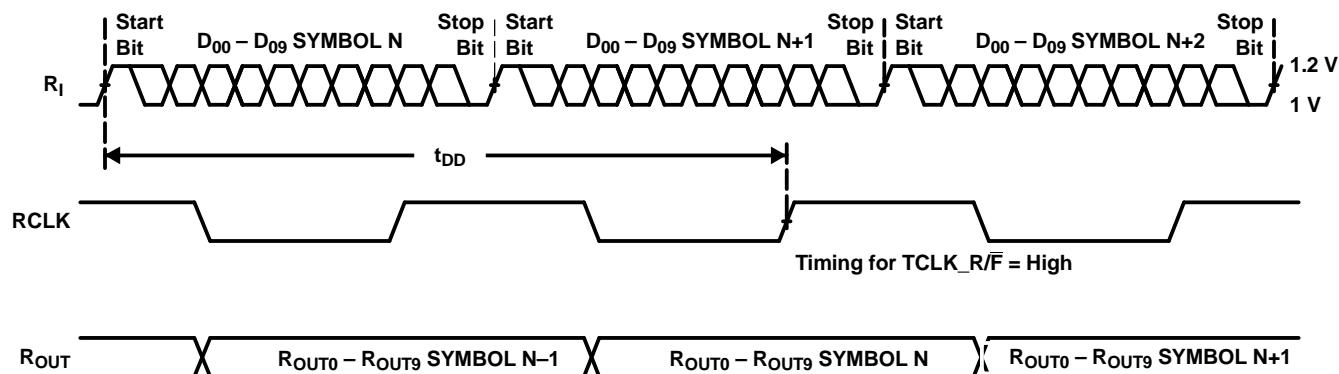


Figure 12. Deserializer Delay

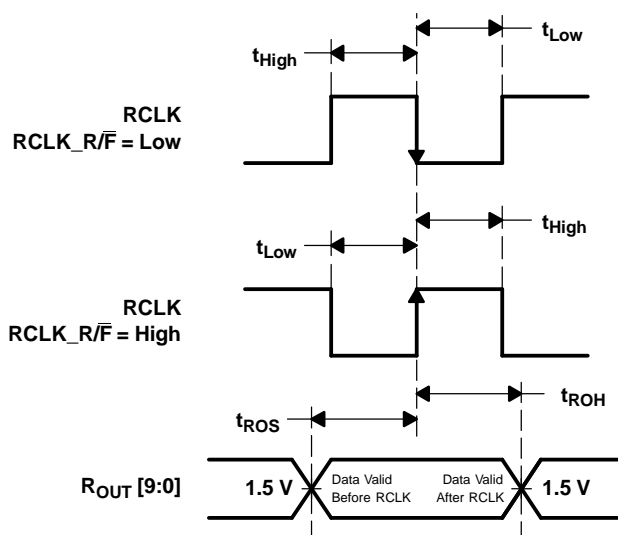


Figure 13. Deserializer Setup and Hold Times

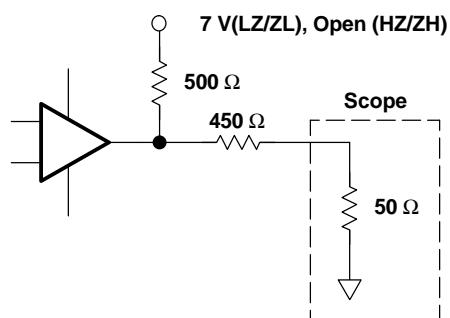


Figure 14. Deserializer High-Impedance-State Test Circuit and Timing

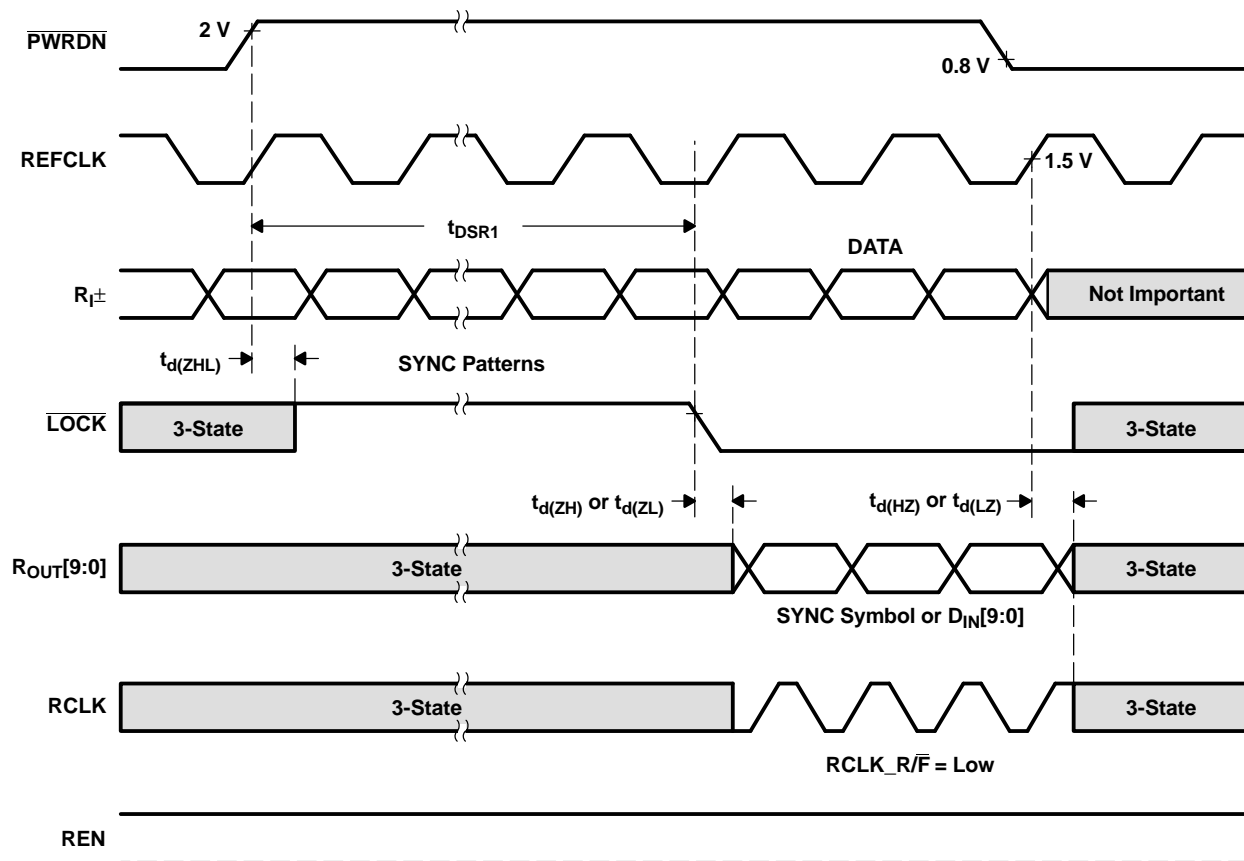


Figure 15. Receiver LVDS Input Skew Margin

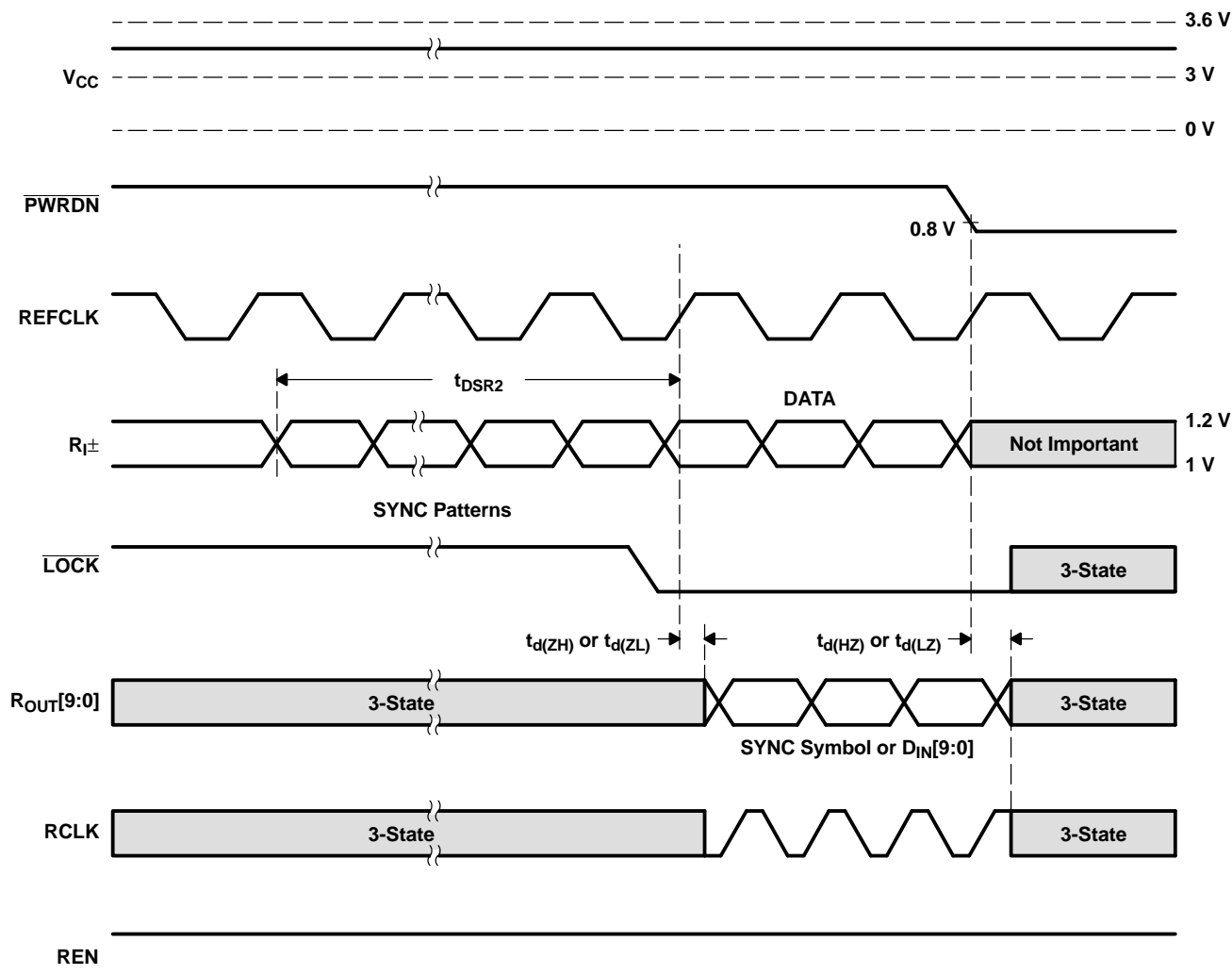
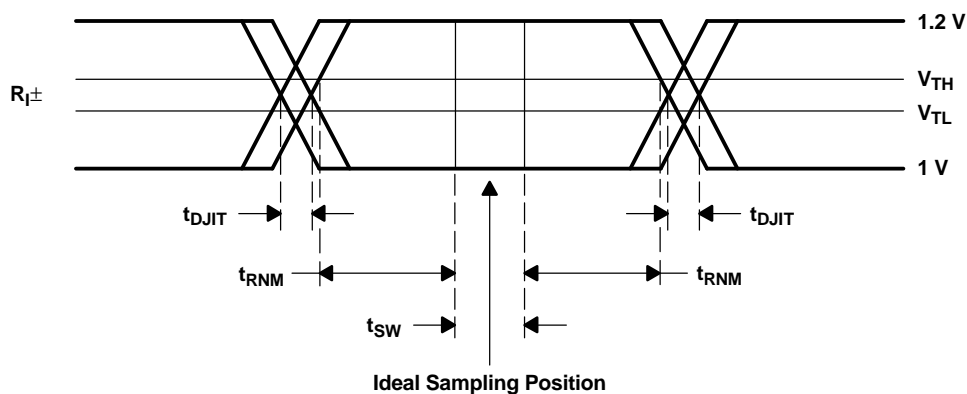


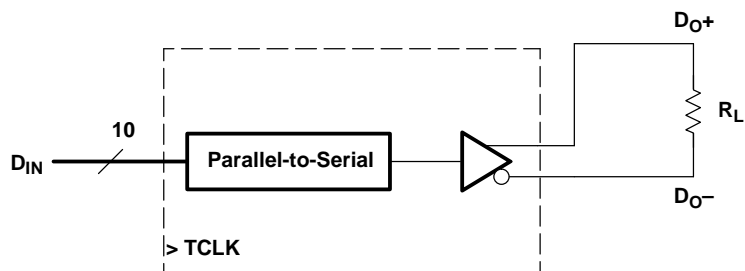
Figure 16. Deserializer PLL Lock Time From SyncPAT



$t_{sw}$ : Setup and Hold Time (Internal Data Sampling Window)  
 $t_{DJIT}$ : Serializer Output Bit Position Jitter That Results From Jitter on TCLK  
 $t_{RNM}$ : Receiver Noise Margin Time

Figure 17. Receiver LVDS Input Skew Margin





$V_{OD} = (D_{O+}) - (D_{O-})$   
 Differential Output Signal Is Shown as  $(D_{O+}) - (D_{O-})$

**Figure 18.  $V_{OD}$  Diagram**

**PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN65LV1021DB	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1021DBG4	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1021DBR	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1021DBRG4	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1212DB	NRND	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1212DBG4	NRND	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1212DBR	NRND	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65LV1212DBRG4	NRND	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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**TAPE AND REEL INFORMATION**



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LV1021DBR	SSOP	DB	28	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
SN65LV1212DBR	SSOP	DB	28	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LV1021DBR	SSOP	DB	28	2000	346.0	346.0	33.0
SN65LV1212DBR	SSOP	DB	28	2000	346.0	346.0	33.0

## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

28 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.  
 D. Falls within JEDEC MO-150

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